



54FCT540

Inverting Octal Buffer/Line Driver with TRI-STATE® Outputs

General Description

The 54FCT540 is an inverting octal buffer and line driver designed to be employed as a memory address driver, clock driver and bus oriented transmitter or receiver which provides improved PC board density.

The 54FCT540 is functionally equivalent to the FCT240 while providing broadside pinout.

The FACT™ FCT utilizes NSC quiet series technology to provide improved quiet output switching and dynamic threshold performance.

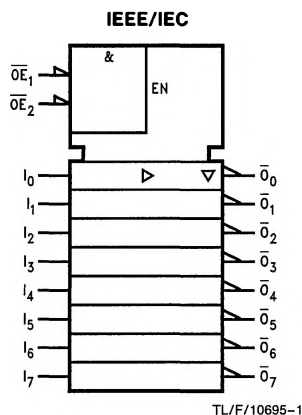
FACT FCT features undershoot corrector and a split ground bus for superior performance.

Features

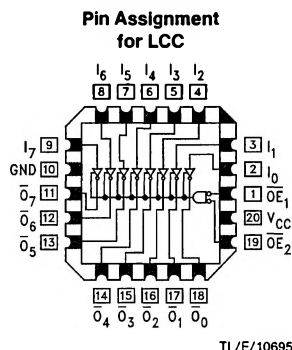
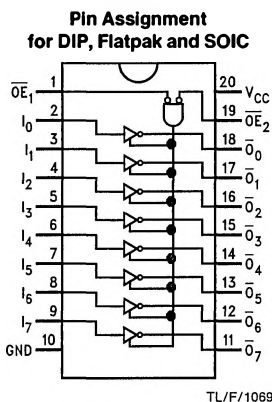
- NSC 54FCT540 is pin and functionally equivalent to IDT 54FCT540
- Controlled output edge rates and undershoot for improved noise immunity. Internal split ground for improved noise immunity
- Input clamp diodes to limit bus reflections
- TTL/CMOS input and output level compatible
- $I_{OL} = 48 \text{ mA}$
- CMOS power levels
- 2 kV minimum ESD immunity
- Military product compliant to MIL-STD 883 and Standard Military Drawing #5962-89767

Ordering Code: See Section 8

Logic Symbol



Connection Diagrams



Truth Table

Pin Names	Description
$\overline{OE}_1, \overline{OE}_2$	TRI-STATE Output Enable Inputs
I_0-I_7	Inputs
$\overline{O}_0-\overline{O}_7$	Outputs

Inputs			Outputs
\overline{OE}_1	\overline{OE}_2	I_n	
L	L	H	L
H	X	X	Z
X	H	X	Z
L	L	L	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = High Impedance

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Terminal Voltage

with Respect to GND (V_{TERM})

54FCT $-0.5V$ to $7.0V$

Temperature under Bias (T_{BIAS})

54FCT $-65^{\circ}C$ to $+135^{\circ}C$

Storage Temperature (T_{STG})

54FCT $-65^{\circ}C$ to $+150^{\circ}C$

Power Dissipation (P_T)

0.5W

DC Output Current (I_{OUT})

120 mA

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. Exposure to absolute maximum rating conditions for extended periods may affect reliability. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables.

Recommended Operating Conditions

Supply Voltage (V_{CC})

54FCT $4.5V$ to $5.5V$

Input Voltage

$0V$ to V_{CC}

Output Voltage

$0V$ to V_{CC}

Operating Temperature (T_A)

54FCT $-55^{\circ}C$ to $+125^{\circ}C$

Junction Temperature (T_J)

CDIP $175^{\circ}C$

PDIP $140^{\circ}C$

DC Characteristics for 'FCT Family Devices

Typical values are at $V_{CC} = 5.0V$, $25^{\circ}C$ ambient and maximum loading. For test conditions shown as Max, use the value specified for the appropriate device type: Com: $V_{CC} = 5.0V \pm 5\%$, $T_A = 0^{\circ}C$ to $+70^{\circ}C$; Mil: $V_{CC} = 5.0V \pm 10\%$, $T_A = -55^{\circ}C$ to $+125^{\circ}C$, $V_{HC} = V_{CC} - 0.2V$.

Symbol	Parameter	54FCT			Units	Conditions	
		Min	Typ	Max			
V_{IH}	Minimum High Level Input Voltage	2.0			V		
V_{IL}	Maximum Low Level Input Voltage			0.8	V		
I_{IH}	Input High Current			5.0 5.0	μA	$V_{CC} = \text{Max}$	$V_I = V_{CC}$ $V_I = 2.7V$ (Note 2)
I_{IL}	Input Low Current			-5.0 -5.0	μA	$V_{CC} = \text{Max}$	$V_I = 0.5V$ (Note 2) $V_I = GND$
I_{OZ}	Maximum TRI-STATE Current			10.0 10.0 -10.0 -10.0	μA	$V_{CC} = \text{Max}$	$V_O = V_{CC}$ $V_O = 2.7V$ (Note 2) $V_O = 0.5V$ (Note 2) $V_O = GND$
V_{IK}	Clamp Diode Voltage	-0.7	-1.2		V	$V_{CC} = \text{Min}; I_N = -18 \text{ mA}$	
I_{OS}	Short Circuit Current	-60	-120		mA	$V_{CC} = \text{Max}$ (Note 1); $V_O = GND$	
V_{OH}	Minimum High Level Output Voltage	2.8	3.0		V	$V_{CC} = 3V; V_{IN} = 0.2V$ or $V_{HC}; I_{OH} = -32 \mu A$	
		V_{HC}	V_{CC}			$V_{CC} = \text{Min}$	$I_{OH} = -300 \mu A$
		2.4	4.3			$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -12 \text{ mA}$ (Mil) $I_{OH} = -15 \text{ mA}$ (Com)
V_{OL}	Maximum Low Level Output Voltage		GND	0.2	V	$V_{CC} = 3V; V_{IN} = 0.2V$ or $V_{HC}; I_{OL} = 300 \mu A$	
			GND	0.2		$V_{CC} = \text{Min}$	$I_{OL} = 300 \mu A$
			0.3	0.55		$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 48 \text{ mA}$ (Mil) $I_{OL} = 64 \text{ mA}$ (Com)
I_{CC}	Maximum Quiescent Supply Current		0.001	1.5	mA	$V_{CC} = \text{Max}$ $V_{IN} \geq V_{HC}; V_{IN} \leq 0.2V$ $I_I = 0$	
ΔI_{CC}	Quiescent Supply Current; TTL Inputs HIGH		0.5	2.0	mA	$V_{CC} = \text{Max}$ $V_{IN} = 3.4V$ (Note 3)	

DC Characteristics for 'FCT Family Devices (Continued)

Typical values are at $V_{CC} = 5.0V$, $25^{\circ}C$ ambient and maximum loading. For test conditions shown as Max, use the value specified for the appropriate device type: Com: $V_{CC} = 5.0V \pm 5\%$, $T_A = 0^{\circ}C$ to $+70^{\circ}C$; Mil: $V_{CC} = 5.0V \pm 10\%$, $T_A = -55^{\circ}C$ to $+125^{\circ}C$, $V_{HC} = V_{CC} - 0.2V$.

Symbol	Parameter	54FCT			Units	Conditions	
		Min	Typ	Max			
I_{CCD}	Dynamic Power Supply Current (Note 4)		0.35	0.4	mA/MHz	$V_{CC} = \text{Max}$ Outputs Open $\overline{OE}_A = \overline{OE}_B = \text{GND}$ One Input Toggling 50% Duty Cycle	$V_{IN} \geq V_{HC}$ $V_{IN} \leq 0.2V$
I_C	Total Power Supply Current (Note 6)			5.5	mA	$V_{CC} = \text{Max}$ Outputs Open $\overline{OE}_A = \overline{OE}_B = \text{GND}$ $f_I = 10 \text{ MHz}$ One Bit Toggling 50% Duty Cycle	$V_{IN} \geq V_{HC}$ $V_{IN} \leq 0.2V$
				6.0			$V_{IN} = 3.4V$ $V_{IN} = \text{GND}$

Note 1: Maximum test duration not to exceed one second, not more than one output shorted at one time.

Note 2: This parameter guaranteed but not tested.

Note 3: Per TTL driven input ($V_{IN} = 3.4V$); all other inputs at V_{CC} or GND.

Note 4: This parameter is not directly testable, but is derived for use in Total Power Supply calculations.

Note 5: Values for these conditions are examples of the I_{CC} formula. These limits are guaranteed but not tested.

Note 6: $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$

$$I_C = I_{CC} + \Delta I_{CC} D_H N_T + I_{CCD} (f_{CP}/2 + f_I N_I)$$

I_{CC} = Quiescent Current

ΔI_{CC} = Power Supply Current for a TTL High Input ($V_{IN} = 3.4V$)

D_H = Duty Cycle for TTL Inputs High

N_T = Number of Inputs at D_H

I_{CCD} = Dynamic Current Caused by an Input Transition Pair (HLH or LHL)

f_{CP} = Clock Frequency for Register Devices (Zero for Non-Register Devices)

f_I = Input Frequency

N_I = Number of Inputs at f_I

All currents are milliamps and all frequencies are in megahertz.

AC Electrical Characteristics: See Section 2 for Waveforms

Symbol	Parameter	54FCT/74FCT	74FCT		54FCT		Units	Fig. No.
		T _A = +25°C V _{CC} = 5.0V	T _A , V _{CC} = Com R _L = 500Ω C _L = 50 pF		T _A , V _{CC} = Mil R _L = 500Ω C _L = 50 pF			
		Typ	Min	Max	Min	Max		
t _{PLH} t _{PHL}	Propagation Delay D _n to O _n	5.0			1.5	9.5	ns	2-8
t _{PZH} t _{PZL}	Output Enable Time	7.0			1.5	12.5	ns	2-11
t _{PHZ} t _{PLZ}	Output Disable Time	6.0			1.5	9.5	ns	2-11

Capacitance $T_A = +25^\circ\text{C}, f = 1.0\text{ MHz}$

Symbol	Parameter (Note)	Typ	Max	Units	Conditions
C_{IN}	Input Capacitance	6	8	pF	$V_{IN} = 0\text{V}$

Note: This parameter is measured at characterization but not tested.